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PCI-6111

NI PCI-6110/6111 Specifications

This document lists the I/O terminal summary and specifications for the NI PCI-6110/6111.

For the most current edition of this document, refer to ni.com/manuals. Refer to the *DAQ Quick Start Guide* for more information about accessing documents on the NI-DAQ CD.



Note With NI-DAQmx, National Instruments has revised its terminal names so they are easier to understand and more consistent among NI hardware and software products. The revised terminal names used in this document are usually similar to the names they replace. For a complete list of Traditional NI-DAQ terminal names and their NI-DAQmx equivalents, refer to the *Terminal Name Equivalents* table in the *S Series Help*.

Table 1. I/O Terminal Summary

Terminal Name	Terminal Type and Direction	Impedance Input/ Output	Protection (Volts) On/Off	Source (mA at V)	Sink (mA at V)	Rise Time (ns)	Bias
AI <0..7>	AI	100 M Ω in parallel with 10 pF	25/15	—	—	—	± 3 nA ± 10 nA
AI GND	—	—	—	—	—	—	—
D GND	—	—	—	—	—	—	—
+5 V	—	0.1 Ω 0.45 Ω	Short-circuit to ground	1 A	—	—	—
P0.<0..7>	DIO	—	$V_{CC} + 0.5$	13 at ($V_{CC} - 0.4$)	24 at 0.4	1.1	50 k Ω pu
EXTSTROBE*	DO	—	—	3.5 at ($V_{CC} - 0.4$)	5 at 0.4	1.5	50 k Ω pu
PFI 0 or PFI 0/ (AI START TRIG or AI START)	DIO	—	$V_{CC} + 0.5$	3.5 at ($V_{CC} - 0.4$)	5 at 0.4	1.5	50 k Ω pu
PFI 1 or PFI 1/ (AI REF TRIG or REF TRIG)	DIO	—	$V_{CC} + 0.5$	3.5 at ($V_{CC} - 0.4$)	5 at 0.4	1.5	50 k Ω pu

Table 1. I/O Terminal Summary (Continued)

Terminal Name	Terminal Type and Direction	Impedance Input/Output	Protection (Volts) On/Off	Source (mA at V)	Sink (mA at V)	Rise Time (ns)	Bias
PFI 2	DIO	—	$V_{CC} + 0.5$	3.5 at $(V_{CC} - 0.4)$	5 at 0.4	1.5	50 k Ω pu
PFI 3 or PFI 3/ (CTR 1 SOURCE or CTR 1 SRC)	DIO	—	$V_{CC} + 0.5$	3.5 at $(V_{CC} - 0.4)$	5 at 0.4	1.5	50 k Ω pu
PFI 4 or PFI 4/ CTR 1 GATE	DIO	—	$V_{CC} + 0.5$	3.5 at $(V_{CC} - 0.4)$	5 at 0.4	1.5	50 k Ω pu
CTR 1 OUT	DO	—	—	3.5 at $(V_{CC} - 0.4)$	5 at 0.4	1.5	50 k Ω pu
PFI 5 or PFI 5/ (AO SAMP CLK or AO SAMP)	DIO	—	$V_{CC} + 0.5$	3.5 at $(V_{CC} - 0.4)$	5 at 0.4	1.5	50 k Ω pu
PFI 6 or PFI 6/ (AO START TRIG or AO START)	DIO	—	$V_{CC} + 0.5$	3.5 at $(V_{CC} - 0.4)$	5 at 0.4	1.5	50 k Ω pu
PFI 7 or PFI 7/ (AI SAMP CLK or AI SAMP)	DIO	—	$V_{CC} + 0.5$	3.5 at $(V_{CC} - 0.4)$	5 at 0.4	1.5	50 k Ω pu
PFI 8 or PFI 8/ (CTR 0 SOURCE or CTR 0 SRC)	DIO	—	$V_{CC} + 0.5$	3.5 at $(V_{CC} - 0.4)$	5 at 0.4	1.5	50 k Ω pu
PFI 9 or PFI 9/ CTR 0 GATE	DIO	—	$V_{CC} + 0.5$	3.5 at $(V_{CC} - 0.4)$	5 at 0.4	1.5	50 k Ω pu
CTR 0 OUT	DO	—	—	3.5 at $(V_{CC} - 0.4)$	5 at 0.4	1.5	50 k Ω pu
FREQ OUT or F OUT	DO	—	—	3.5 at $(V_{CC} - 0.4)$	5 at 0.4	1.5	50 k Ω pu
* Indicates active low AI = Analog Input DIO = Digital Input/Output pu = pull-up AO = Analog Output DO = Digital Output Note: The tolerance on the 50 kΩ pull-up resistors is large. Actual value might range between 17 kΩ and 100 kΩ.							

Specifications

The following specifications are typical at 25 °C unless otherwise noted.

Analog Input

Input Characteristics

Number of channels

NI PCI-6110..... 4 pseudodifferential

NI PCI-6111..... 2 pseudodifferential

Type of ADC

Resolution 12 bits, 1 in 4,096

Pipeline 3

Sampling rate

Maximum..... 5 MS/s

Minimum 1 kS/s

Input coupling DC or AC

Maximum working voltage for all AI channels

Input Channels	Range	Maximum Working Voltage (Signal + Common Mode)
AI <0..3>+	20 mV to 10 V	Should remain within ± 11 V of ground
	20 to 42 V	Should remain within ± 42 V of ground
AI <0..3>–	All	Should remain within ± 11 V of ground

Overvoltage protection..... ± 42 V

Inputs protected

Positive input All channels

Negative input..... All channels

FIFO buffer size 8,192 samples

Data transfers DMA, interrupts,
programmed I/O

DMA modes Scatter-gather (single transfer,
demand transfer)

Accuracy Information

Table 2. NI 6110/6111 Analog Input DC Accuracy Information

Full Scale Nominal Range (V)	Absolute Accuracy							Relative Accuracy	
	% of Reading			Offset (mV)	Noise + Quantization (mV)		Temp Drift (%/°C)	Resolution (mV)	
	24 Hours	90 Days	1 Year		Single Pt.	Averaged		Theoretical	Averaged
±42	0.51	0.51	0.51	35	51	4.4	0.0005	24	5.8
±20	0.51	0.51	0.51	20	20	1.8	0.0005	9.8	2.3
±10	0.11	0.11	0.11	5.7	10	0.88	0.0005	4.9	1.2
±5	0.057	0.058	0.059	3	5.1	0.44	0.0005	2.4	0.58
±2	0.057	0.058	0.059	1.3	2	0.18	0.0005	0.98	0.23
±1	0.057	0.058	0.059	0.7	1	0.088	0.0005	0.49	0.12
±0.5	0.057	0.058	0.059	0.4	0.67	0.059	0.0005	0.24	0.077
±0.2	0.057	0.058	0.059	0.2	0.39	0.035	0.0005	0.098	0.046
Note: Accuracies are valid for measurements following an internal calibration. Measurement accuracies are listed for operational temperatures within ±1 °C of internal calibration temperature and ±10 °C of external or factory calibration temperature. A one-year calibration interval is recommended.									

Transfer Characteristics

INL.....±0.5 LSB typ, ±1 LSB max

DNL±0.3 LSB typ, ±0.75 LSB max

Spurious free dynamic range (SFDR)Refer to Table 3

Effective number of bits (ENOB).....11.0 bits, DC to 100 kHz

Amplifier Characteristics

Input impedance

AI <0..3>+ to AI <0..3>–

Normal powered on1 MΩ in parallel with 100 pF

Powered off1 MΩ minimum

Overload1 MΩ

Impedance to ground

AI <0..3>– to ground100 GΩ in parallel with 10 nF

Input bias current±300 pA

Input offset current±200 pA

Dynamic Characteristics

Crosstalk..... –80 dB, DC to 100 kHz

Table 3. Analog Input Characteristics

Input Range	Bandwidth ¹ (MHz)	SFDR Typ ² (dB)	SFDR Max (dB)	CMRR ³ (dB)	System Noise ⁴ (LSB _{rms})
±42 V	5.5	78	70	34	0.5
±20 V	4.4	78	70	40	0.5
±10 V	7.2	81	75	46	0.5
±5 V	4.8	81	75	52	0.5
±2 V	4.8	85	75	60	0.5
±1 V	4.4	85	75	66	0.5
±500 mV	4.4	85	75	70	0.6
±200 mV	4.1	81	70	72	1.0
¹ –3 dB frequency for input amplitude at 96% of the input range (–0.3 dB) ² Measured at 100 kHz ³ DC to 60 Hz ⁴ LSB _{rms} , not including quantization					



Note Bandwidth specifications are for signals on the (+) input with the (–) input at DC ground. The (–) input is slew rate limited to 24 V/μs and has an additional 10 nF capacitance to ground.

Stability

Recommended warm-up time 15 minutes

Calibration interval 1 year

Offset temperature coefficient

Pregain ±5 μV/°C

Postgain..... ±50 μV/°C

Gain temperature coefficient..... ±20 ppm/°C

Onboard calibration reference

Level.....	5.000 V (± 2.5 mV)
	(actual value stored in EEPROM)
Temperature coefficient.....	± 2.0 ppm/°C max
Long-term stability	± 6 ppm/√1,000 h

Analog Output

Output Characteristics

Number of channels	2 voltage
Resolution	16 bits, 1 in 65,536
Max update rate	
1 channel.....	4 MS/s, system dependent
2 channel.....	2.5 MS/s, system dependent
FIFO buffer size.....	2,048 samples
Data transfers	DMA, interrupts, programmed I/O
DMA modes	Scatter-gather (single transfer, demand transfer)

Transfer Characteristics

Relative accuracy (INL) ± 4 LSB typ, ± 8 LSB max
DNL ± 2 LSB typ, ± 8 LSB max

Table 4. NI PCI-6110/6111 Analog Output DC Accuracy Information

Nominal Range (V)	Absolute Accuracy				
	% of Reading		Offset (mV)	Temp Drift (%/°C)	Absolute Accuracy at Full Scale (± mV)
	24 Hrs	1 Year			
±10	0.018	0.022	5.933	0.0005	8.133
Note: Temp Drift applies only if ambient is greater than ±10 °C of previous external calibration.					

Voltage Output

Range ± 10 V

Output coupling DC

Output impedance 50 Ω , $\pm 5\%$

Short circuit current ± 27 mA typ

Current drive ± 5 mA min

Output stability..... Any passive load

Protection Short-circuit to ground

Power-on output voltage 0, ± 400 mV (before software loads calibration values)

Dynamic Characteristics

Settling time and slew rate

Settling Time for Full-Scale Step	Slew Rate
300 ns to $\pm 0.01\%$	300 V/ μ s

Noise 1 mV_{rms}, DC to 5 MHz

Spurious free dynamic range..... 75 dB, DC to 10 kHz

Glitch energy..... ± 30 mV for 1 μ s

Stability

Offset temperature coefficient ± 500 μ V/ $^{\circ}$ C

Gain temperature coefficient

Internal reference ± 50 ppm/ $^{\circ}$ C

External reference ± 25 ppm/ $^{\circ}$ C

Onboard calibration reference

Level 5.000 V (± 2.5 mV)
(actual value stored in EEPROM)

Temperature coefficient..... ± 2.0 ppm/ $^{\circ}$ C max

Long-term stability ± 6 ppm/ $\sqrt{1,000}$ h

Digital I/O

Number of channels 8 input/output

Compatibility TTL/CMOS

Digital logic levels

Level	Min	Max
Input low voltage	0.0 V	0.8 V
Input high voltage	2.0 V	5.0 V
Input low current ($V_{in} = 0$ V)	—	–320 μ A
Input high current ($V_{in} = 5$ V)	—	10 μ A
Output low voltage ($I_{OL} = 24$ mA)	—	0.4 V
Output high voltage ($I_{OH} = -13$ mA)	4.35 V	—

Power-on stateInput (high-impedance)

Data transfersProgrammed I/O

Timing I/O

Counter/Timers

Number of channels2

Resolution24 bits

CompatibilityTTL/CMOS

Digital logic levels

Level	Min	Max
Input low voltage	0 V	0.8 V
Input high voltage	2 V	5 V
Output low voltage ($I_{OL} = 5$ mA)	—	0.4 V
Output high voltage ($I_{OH} = -3.5$ mA)	4.35 V	—

Base clocks available20 MHz, 100 kHz

Base clock accuracy $\pm 0.01\%$

Max source frequency20 MHz

Min source pulse duration10 ns, edge-detect mode

Min gate pulse duration10 ns, edge-detect mode

Data transfers DMA, interrupts,
programmed I/O

DMA modes..... Scatter-gather (single transfer,
demand transfer)

Frequency Scaler

Number of channels 1

Resolution 4 bits, 1 in 16

Compatibility TTL/CMOS

Digital logic levels

Level	Min	Max
Input low voltage	0 V	0.8 V
Input high voltage	2 V	5 V
Output low voltage ($I_{out} = 5 \text{ mA}$)	—	0.4 V
Output low voltage ($I_{out} = -3.5 \text{ mA}$)	4.35 V	—

Base clocks available 10 MHz, 100 kHz

Base clock accuracy $\pm 0.01\%$

Data transfers DMA, interrupts,
programmed I/O

Triggers

Analog Trigger

Number of triggers 1

Purpose

 Analog input Start, reference, and pause trigger,
sample clock

 Analog output Start and pause trigger,
sample clock

 General-purpose counter/timers..... Source, gate

Source..... All analog input channels,
external trigger
(PFI 0/ AI START TRIG)

Level

Internal source, AI <0..3> $\pm$ Full-scale

External source, PFI 0/

AI START TRIG ± 10 V

Slope Positive or negative
(software-selectable)

Resolution 8 bits, 1 in 256

Hysteresis Programmable

Bandwidth (–3 dB)

Internal source, AI <0..3> 5 MHz

External source, PFI0/TRIG1 5 MHz

Digital Trigger

Purpose

Analog input Start, reference, and pause trigger,
sample clock

Analog output Start and pause trigger,
sample clock

General-purpose counter/timers Source, gate

External sources PFI <0..9>, RTSI <0..6>

Compatibility 5 V/TTL

Response Rising or falling edge

Pulse width 10 ns min

External Input for Digital or Analog Trigger (PFI 0/AI START TRIG)

Output impedance 10 k Ω

Source impedance (recommended) 1 k Ω

Coupling DC or AC

Protection

Digital trigger –0.5 V to ($V_{CC} + 0.5$) V

Analog trigger

On/disabled ± 35 V

Powered off ± 35 V

RTSI

Trigger lines 7

Bus Interface

Type Master, slave

Power Requirement

+5 VDC ($\pm 5\%$)

NI PCI-6110..... 2.5 A

NI PCI-6111..... 2.0 A

Power available at I/O connector +4.65 to +5.25 VDC at 1 A

Physical

Dimensions

(not including connectors) 31.2 cm by 10.6 cm
(12.3 in. by 4.2 in.)

I/O connector..... 68-pin male SCSI-II type

Maximum Working Voltage

Maximum working voltage refers to the signal voltage plus the common-mode voltage.

Channel-to-earth..... 42 V, Installation Category I

Channel-to-channel 42 V, Installation Category I

Environmental

Operating temperature..... 0 to 45 °C

Storage temperature -20 to 70 °C

Humidity 5 to 90% RH, noncondensing

Maximum altitude 2,000 m

Pollution Degree (indoor use only) 2



Note Clean the device with a soft, non-metallic brush. Make sure that the device is completely dry and free from contaminants before returning it to service.

Safety

This product is designed to meet the requirements of the following standards of safety for electrical equipment for measurement, control, and laboratory use:

- IEC 61010-1, EN 61010-1
- UL 3111-1, UL 61010B-1
- CAN/CSA C22.2 No. 1010.1



Note For UL and other safety certifications, refer to the product label, or visit ni.com/hardref.nsf, search by model number or product line, and click the appropriate link in the Certification column.

Electromagnetic Compatibility

Emissions.....	EN 55011 Class A at 10 m FCC Part 15A above 1 GHz
Immunity	EN 61326:1997A2:2001, Table 1
EMC/EMI	CE, C-Tick, and FCC Part 15 (Class A) Compliant



Note For EMC compliance, you *must* operate this device with shielded cabling.

CE Compliance

This product meets the essential requirements of applicable European Directives, as amended for CE marking, as follows:

Low-Voltage Directive (safety).....	73/23/EEC
Electromagnetic Compatibility Directive (EMC)	89/336/EEC



Note Refer to the Declaration of Conformity (DoC) for this product for any additional regulatory compliance information. To obtain the DoC for this product, visit ni.com/hardref.nsf, search by model number or product line, and click the appropriate link in the Certification column.

